IGBT - Field Stop, Trench 650 V, 75 A

FGH75T65SQDT

Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 4th generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Features

- Max Junction Temperature $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: V_{CE(sat)} = 1.6 V (Typ.) @ I_C = 75 A
- 100% of the Parts Tested for ILM
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- This Device is Pb-Free and is RoHS Compliant

Applications

• Solar Inverter, UPS, Welder, Telecom, ESS, PFC

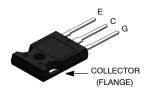


ON Semiconductor®

www.onsemi.com

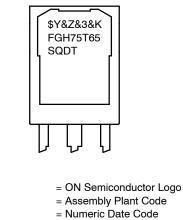
V _{CES}	Ι _C
650 V	75 A





TO-247-3LD CASE 340CH

MARKING DIAGRAM



= Numeric Date
= Lot Code

&K FGH75T65SQDT = Specific Device Code

\$Y

&Z

&3

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

Symbol	Description		FGH50T65SQD-F155	Unit	
V _{CES}	Collector to Emitter Voltage		650	V	
V _{GES}	Gate to Emitter Voltage		±20	V	
	Transient Gate to Emitter Voltage		±30	V	
Ι _C	Collector Current	$T_{C} = 25^{\circ}C$	150	А	
		T _C = 100°C	75	А	
I _{LM} (Note 1)	Pulsed Collector Current	T _C = 25°C	300	А	
I _{CM} (Note 2)	Pulsed Collector Current	Jsed Collector Current		А	
١ _F	Diode Forward Current	T _C = 25°C	150	А	
	Diode Forward Current	T _C = 100°C	75	А	
I _{FM}	Pulsed Diode Maximum Forward Current	!	300	А	
PD	Maximum Power Dissipation	T _C = 25°C	375	W	
		T _C = 100°C	188	W	
TJ	Operating Junction Temperature	•	–55 to +175	°C	
T _{STG}	Storage Temperature Range		–55 to +175	°C	
ΤL	Maximum Lead Temp. for Soldering Purpos	ses, 1/8" from Case for 5 Seconds	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. $V_{CC} = 400 \text{ V}$, $V_{GE} = 15 \text{ V}$, $I_C = 300 \text{ A}$, $R_G = 21 \Omega$, Inductive Load. 2. Repetitive rating: Pulse width limited by max. junction temperature.

THERMAL CHARACTERISTICS

Symbol	Parameter	FGH75T65SQDT-F155	Unit
R _{θJC} (IGBT)	Thermal Resistance, Junction to Case, Max.	0.4	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	0.65	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Qty per Tube
FGH75T65SQDT-F155	FGH75T65SQDT	TO-247-3LD	Tube	-	-	30

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS			•		
BV _{CES}	Collector to Emitter Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	650	-	-	V
$\Delta \text{BV}_{\text{CES}} / \Delta \text{T}_{\text{J}}$	Temperature Coefficient of Breakdown Voltage	I_{C} = 1 mA, Reference to 25°C	_	0.6	-	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	250	μΑ
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	-	-	±400	nA
ON CHARACTE	RISTICS					
V _{GE(th)}	G-E Threshold Voltage	I_C = 75 mA, V_{CE} = V_{GE}	2.6	4.5	6.4	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I_{C} = 75 A, V _{GE} = 15 V, T _C = 25 °C	-	1.6	2.1	V
		I _C = 75 A, V _{GE} = 15 V, T _C = 175°C	-	1.92	-	V
DYNAMIC CHA	RACTERISTICS					
Cies	Input Capacitance	$V_{CE} = 30 \text{ V}, \text{ V}_{GE} = 0 \text{ V},$	-	4845	-	pF
C _{oes}	Output Capacitance	f = 1MHz	-	155	-	pF
C _{res}	Reverse Transfer Capacitance	<u> </u>	_	14	-	pF
SWITCHING CH	IARACTERISTICS					
T _{d(on)}	Turn–On Delay Time		-	23	-	ns
Tr	Rise Time		-	10	-	ns
T _{d(off)}	Turn–Off Delay Time		-	120	-	ns
Τ _f	Fall Time	1	-	7	-	ns
Eon	Turn–On Switching Loss	1	-	300	-	μJ
E _{off}	Turn–Off Switching Loss] [-	70	-	μJ
E _{ts}	Total Switching Loss		-	370	-	μJ
T _{d(on)}	Turn-On Delay Time	V_{CC} = 400 V, I _C = 37,5 A, R _G = 4.7 Ω, V _{GE} = 15 V,	-	26	-	ns
Tr	Rise Time	Inductive Load, $T_C = 25^{\circ}C$	-	19	-	ns
T _{d(off)}	Turn-Off Delay Time		-	114	-	ns
Τ _f	Fall Time] [-	11	-	ns
Eon	Turn–On Switching Loss] [-	746	-	μJ
E _{off}	Turn–Off Switching Loss] [-	181	-	μJ
E _{ts}	Total Switching Loss		-	927	-	μJ
T _{d(on)}	Turn–On Delay Time	V_{CC} = 400 V, I _C = 18.5 A, R _G = 4.7 Ω, V _{GE} = 15 V,	-	22	-	ns
T _r	Rise Time	Inductive Load, $T_C = 175^{\circ}C$	-	12	-	ns
T _{d(off)}	Turn–Off Delay Time] [-	135	-	ns
Τ _f	Fall Time	ן ר	-	14	-	ns
Eon	Turn–On Switching Loss	ן ן	-	760	-	μJ
E _{off}	Turn–Off Switching Loss	1 1	-	180	-	μJ
E _{ts}	Total Switching Loss	-1	_	940	_	μJ

ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_C = 25^{\circ}C$ unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit				
SWITCHING C	VITCHING CHARACTERISTICS									
T _{d(on)}	Turn-On Delay Time	V _{CC} = 400 V, I _C = 37.5 A, R _G = 4.7 Ω, V _{GE} = 15 V,	-	24	-	ns				
T _r	Rise Time	Inductive Load, $T_C = 175^{\circ}C$	-	24	-	ns				
T _{d(off)}	Turn-Off Delay Time		-	125	-	ns				
T _f	Fall Time		-	10	-	ns				
Eon	Turn-On Switching Loss		-	1520	I	μJ				
E _{off}	Turn-Off Switching Loss		-	401	-	μJ				
E _{ts}	Total Switching Loss		-	1921	-	μJ				
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 75 A, V _{GE} = 15 V	-	128	-	nC				
Q _{ge}	Gate to Emitter Charge	VGE = 13 V	-	23	-	nC				
Q _{gc}	Gate to Collector Charge		-	29	-	nC				

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS OF THE DIODE (T_C = 25° C unless otherwise noted)

Symbol	Parameter	Test Co	Min	Тур	Max	Unit	
V _{FM}	Diode Forward Voltage	I _F = 75 A	$T_C = 25^{\circ}C$	-	1.8	2.1	V
			T _C = 175°C	-	1.7	-	1
E _{rec}	Reverse Recovery Energy	I _F = 75 A, dI _F /dt = 200 A/μs	T _C = 175°C	-	160	-	μJ
T _{rr}	Diode Reverse Recovery Time	ui _F /ut = 200 Α/μ3	$T_{C} = 25^{\circ}C$	-	76	-	ns
			T _C = 175°C	-	270	-	1
Q _{rr}	Diode Reverse Recovery Charge	1	$T_{C} = 25^{\circ}C$	-	206	-	nC
			T _C = 175°C	-	2199	-	1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

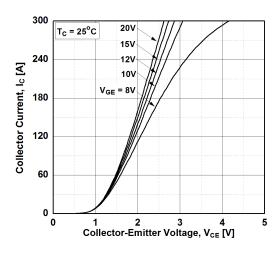


Figure 1. Typical Output Characteristics

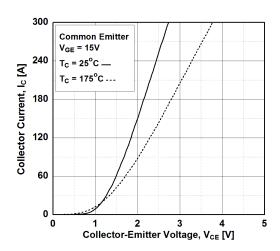


Figure 3. Typical Saturation Voltage Characteristics

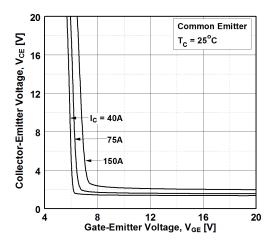


Figure 5. Saturation Voltage vs. V_{GE}

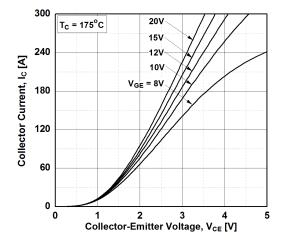


Figure 2. Typical Output Characteristics

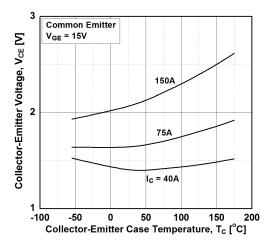


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

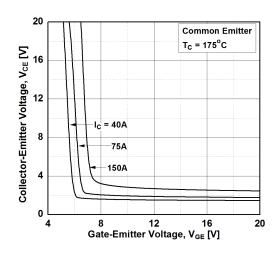


Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL CHARACTERISTICS (Continued)

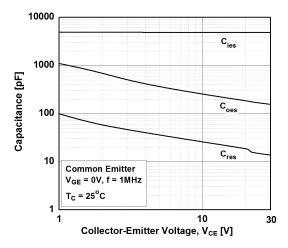


Figure 7. Capacitance Characteristics

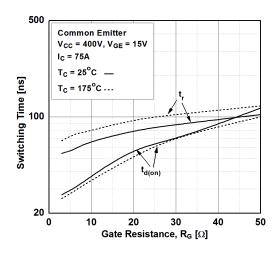
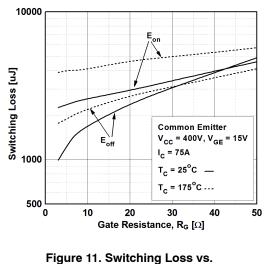


Figure 9. Turn-on Characteristics vs. Gate Resistance



Gate Resistance

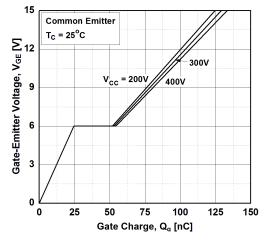


Figure 8. Gate Charge Characteristics

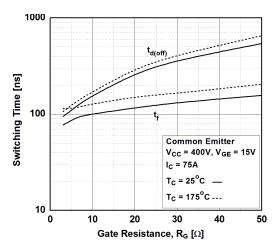
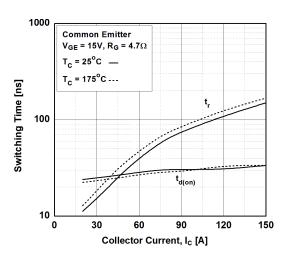
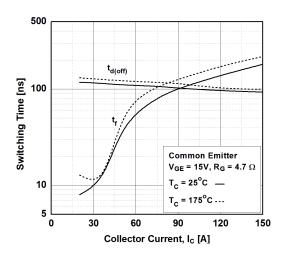


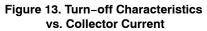
Figure 10. Turn-off Characteristics vs. Gate Resistance





TYPICAL CHARACTERISTICS (Continued)





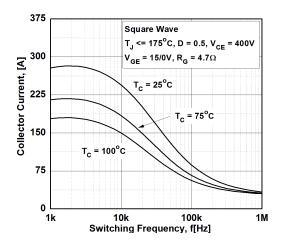


Figure 15. Load Current vs. Frequency

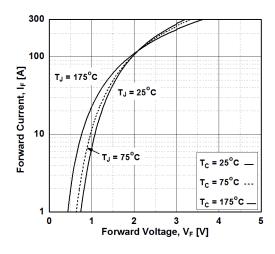


Figure 17. Forward Characteristics

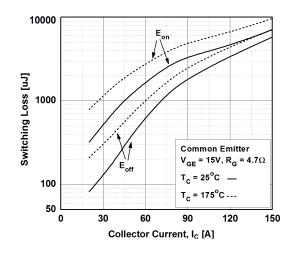


Figure 14. Switching Loss vs. Collector Current

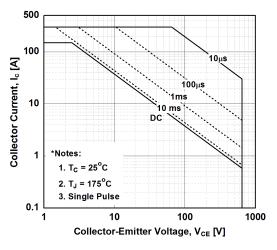


Figure 16. SOA Characteristics

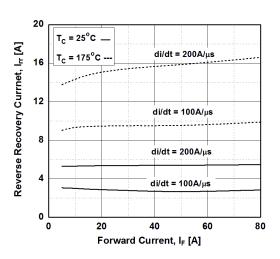


Figure 18. Reverse Recovery Current

TYPICAL CHARACTERISTICS (Continued)

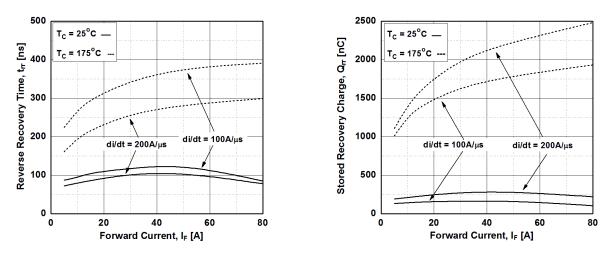


Figure 19. Reverse Recovery Time



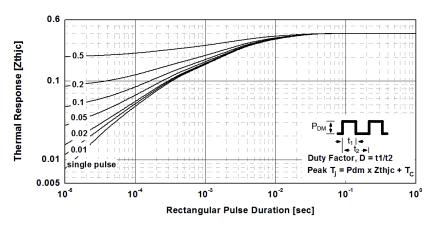


Figure 21. Transient Thermal Impedance of IGBT

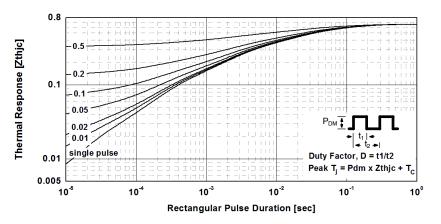
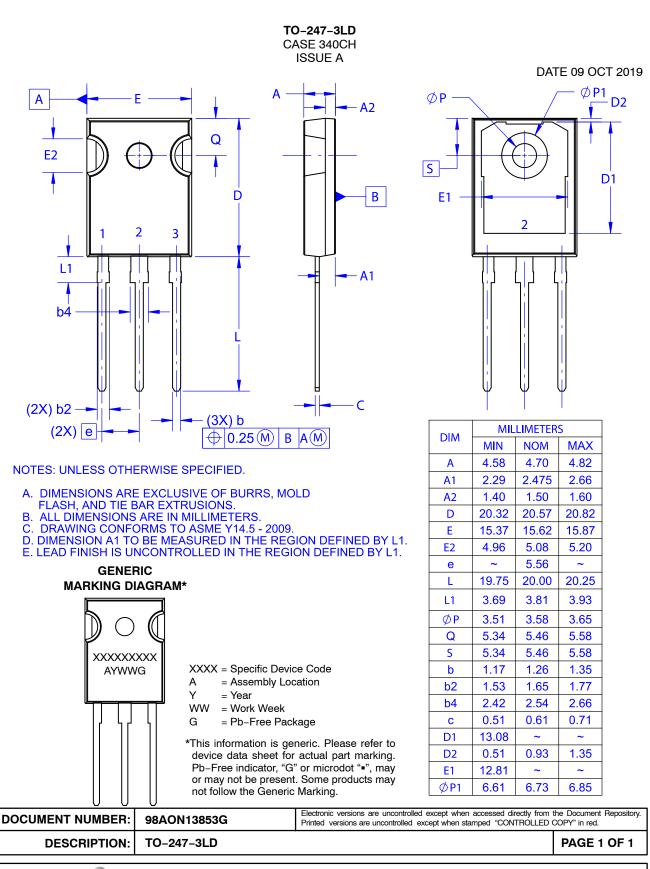


Figure 22. Transient Thermal Impedance of Diode





ON Semiconductor and use trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and calcular performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

TECHNICAL SUPPORT

onsemi Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Onsemi: FGH75T65SQDT-F155